

# Search Notes



Application/Control No.

10/664,379

Examiner

Long Nguyen

Applicant(s)/Patent under Reexamination

BENZER ET AL.

Art Unit

2816

## SEARCHED

Class	Subclass	Date	Examiner
327	333, 427, 581, 112, 309, 310, 313, 327, 328, 434-437	2/3/05	LN
32C	68, 81, 80, 63		
365	189-11		
Search	above	6/23/05	LN
327	108-111, 170, 379, 389, 391		
326	82-83, 26, 27		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East	2/3/05	LN